APPROVAL SHEET

Customer Name	:	
Customer P/N	:	
Frequency	: 4.000000	MHz
Aker Approved P/N	: SMA-004000-5BL4T2	
Aker MPN	: SMA-004000-5BL4T2	
Rev.	: 1	
ISSUE DATE	: Jan.25.2019	

APPROVED	CHECKED	PREPARED
Tim		Kiku
APPROVED BY CUSTOMER		

AKER TECHNOLOGY CO., LTD.

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Web: www.aker.com.tw

RoHS compliant

Accurate Kinetic Energy

CUST. P/N	:		
Aker Approved P/N	:	SMA-004000-5BL4T2	
APPROVED	:	Tin	SHEET : 1 of 10
PREPARED	:	Kiku	REV . : 1

Rev.	Date	Reviser	Revise contents
1	2019/1/25	Kiku	Initial Released

SMD CRYSTAL OSCILLATOR

1 . ELECTRICAL CHARACTERISTICS

■ Standard atmospheric conditions

Unless otherwise specified , the standard range of atmospheric conditions for making measurement and tests are as follow :

Ambient temperature : 25±5℃

Relative humidity : 40%~70%

If there is any doubt about the results , measurement shall be made within the following limits :

Ambient temperature : 25±3℃

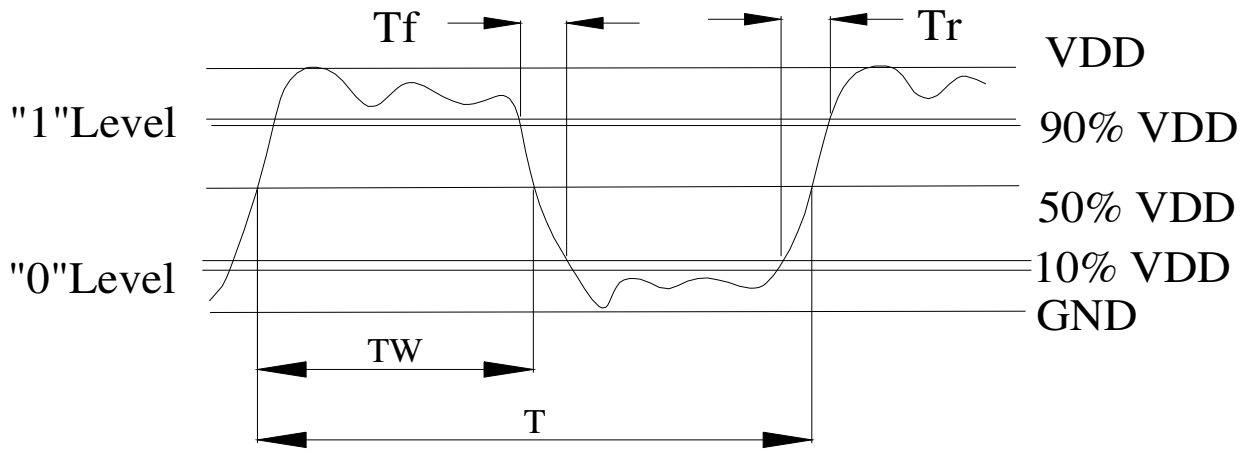
Relative humidity : 40%~70%

■ AKER Model : SMA-531

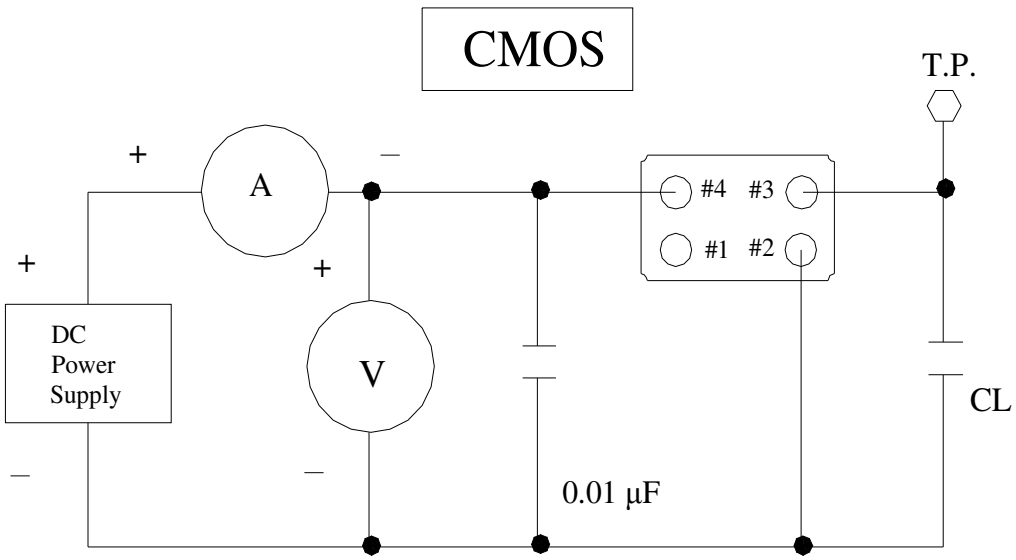
■ Cutting Model : AT CUT

Parameters	Symbol	Electrical Spec				Notes
		Min.	Typ.	Max.	Units.	
Nominal Frequency			4.000000		MHz	
Frequency Stability			± 50		ppm	
Supply Voltage	V_{DD}		3.3 ± 10%		V	
Output Load CMOS	CL		15		pF	
Aging			±3		ppm	First Year
Enable Control			Yes			Pad 1
Operating Temperature		-40	25	85	℃	
Storage Temperature Range		-55	~	125	℃	
Output Voltage High	VoH	2.97			V	
Output Voltage Low	VoL			0.33	V	
Input Current	Icc			7	mA	
Standby Current	I_{ST}			10	μA	
Rise Time	Tr			10	ns	10%~90%V_{DD} Level
Fall Time	Tf			10	ns	10%~90%V_{DD} Level
Symmetry (Duty ratio)	TH/T	40	~	60	%	
Start-up Time	Tosc			10	ms	
Enable Voltage High	Vhi	70%V_{DD}			V	
Disable Voltage Low	Vlo			30%V_{DD}	V	
Output Enable Delay Time	T on			10	ms	
Output Disable Delay Time	T off			200	ns	

2 . C - MOS LOAD OUTPUT WAVEFORM

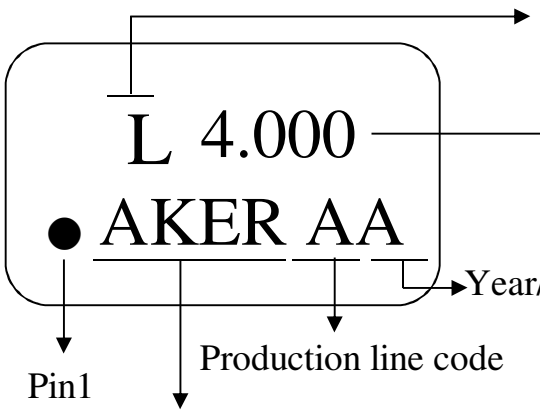


3 . C - MOS LOAD TEST CIRCUIT



***Because SMA series has no by pass capacitor.
So,we recommend our customer to use capacitor 0.01 µF
in join Vcc and GND.

4 . MARKING :



NOTE1:

T	5.0V TTL
C	4.5~5.0V CMOS
L	2.97~3.63V TTL&CMOS
R	2.8~3.0V CMOS
S	2.25~2.75V CMOS
Y	1.5~2.0V CMOS
Z	0.8~1.4V CMOS
W	Voltage Range CMOS

Year / Month	2007	2008	2009	2010
	2011	2012	2013	2014
	2015	2016	2017	2018
	2019	2020	2021	2022
	2023	2024	2025	2026
JAN	A	N	a	n
FEB	B	P	b	p
MAR	C	Q	c	q
APR	D	R	d	r
MAY	E	S	e	s
JUN	F	T	f	t
JUL	G	U	g	u
AUG	H	V	h	v
SEP	J	W	j	w
OCT	K	X	k	x
NOV	L	Y	l	y
DEC	M	Z	m	z

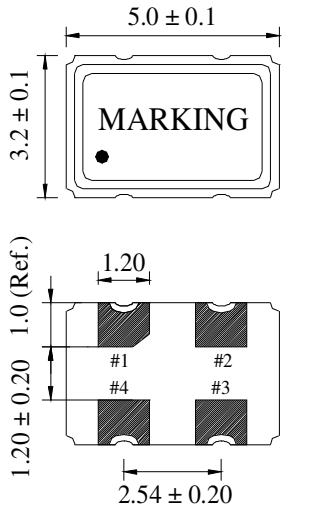
5 . DIMENSION :

(UNIT : mm)

Enable / Disable Function

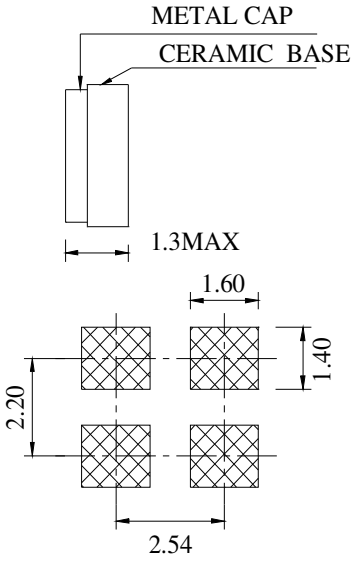
E/D (#1)	OUTPUT (#3)
HIGH (Open)	Operating
LOW	High impedance

PIN FUNCTION
#1 : Enable / Disable Control
#2 : GND
#3 : OUTPUT
#4 : VDD



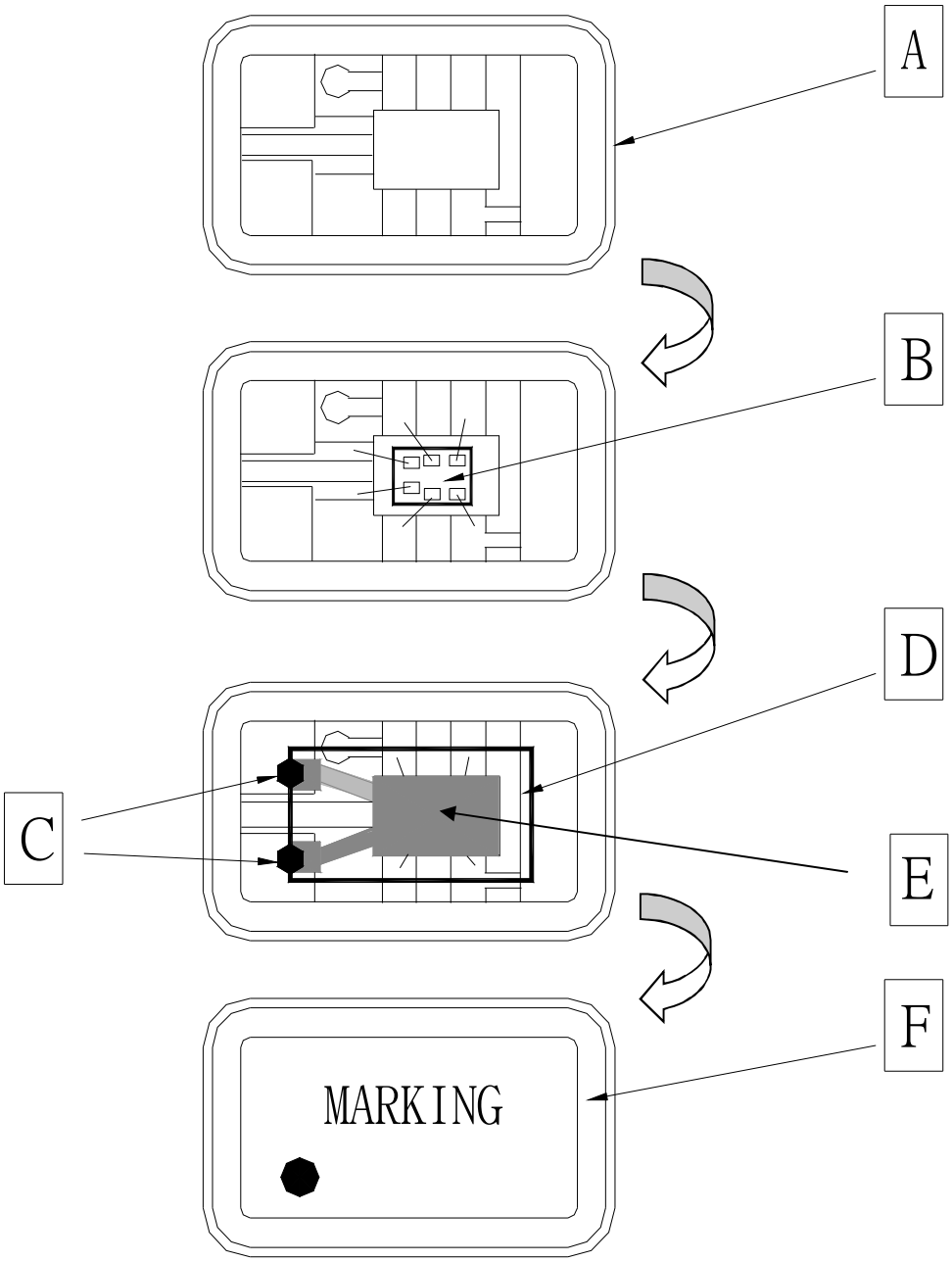
#1 : E/D #2 : GND
#4 : VDC #3 : OUTPUT

Bottom



(Recommended Land Pattern)

6 . STRUCTURE ILLUSTRATION

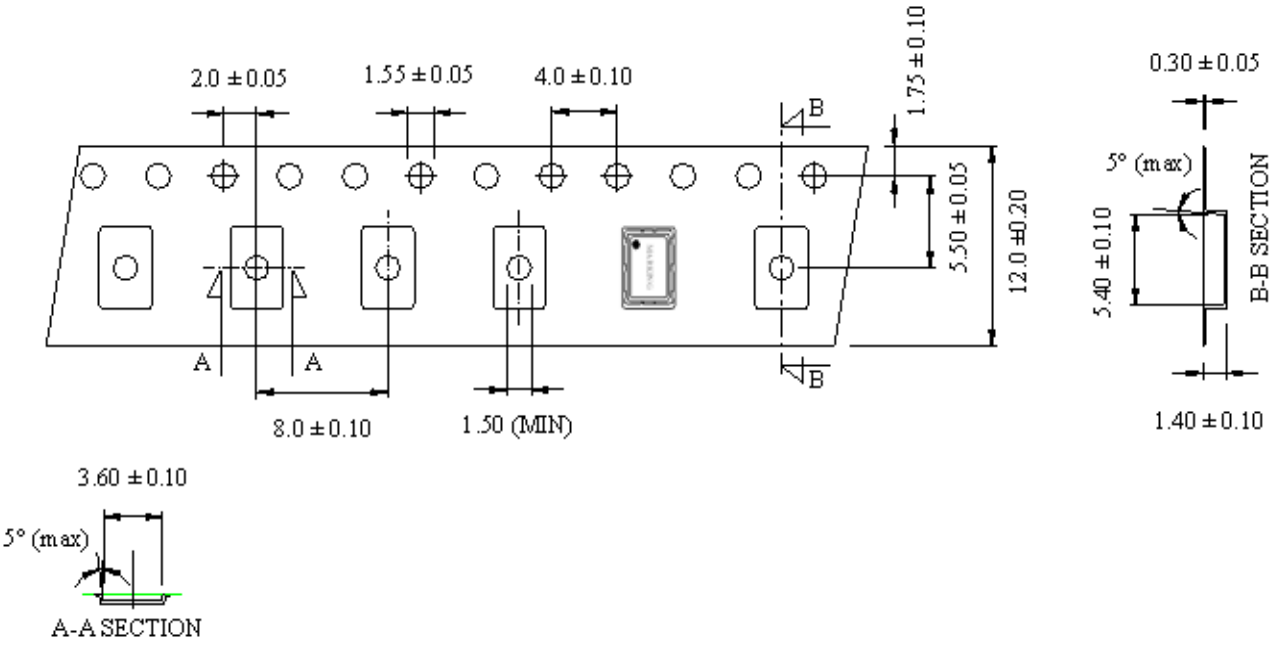


COMPONENTS		MATERIALS	COMPONENTS		MATERIALS
A	Base (Package)	Ceramic (Al_2O_3)+Kovar (Fe/Co/Ni)	D	Crystal blank	SiO_2
B	IC chip	-	E	Electrode	Cr / Ag
C	Conductive adhesive	Ag / Silicon resin	F	Lid	Fe/Co/Ni

7 . PACKING :

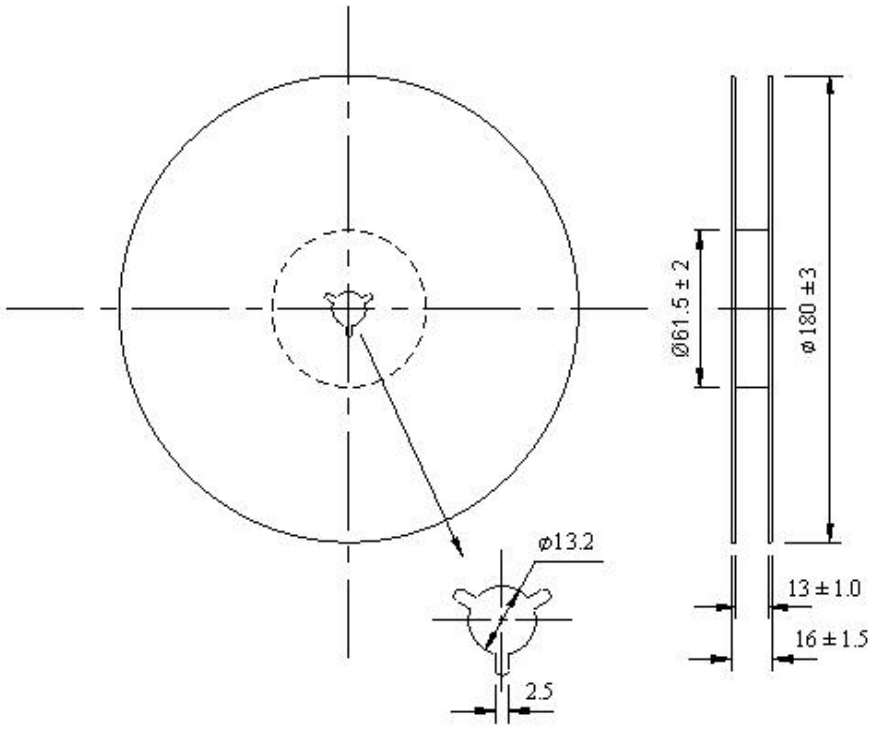
TAPE SPECIFICATION

(Unit : mm)

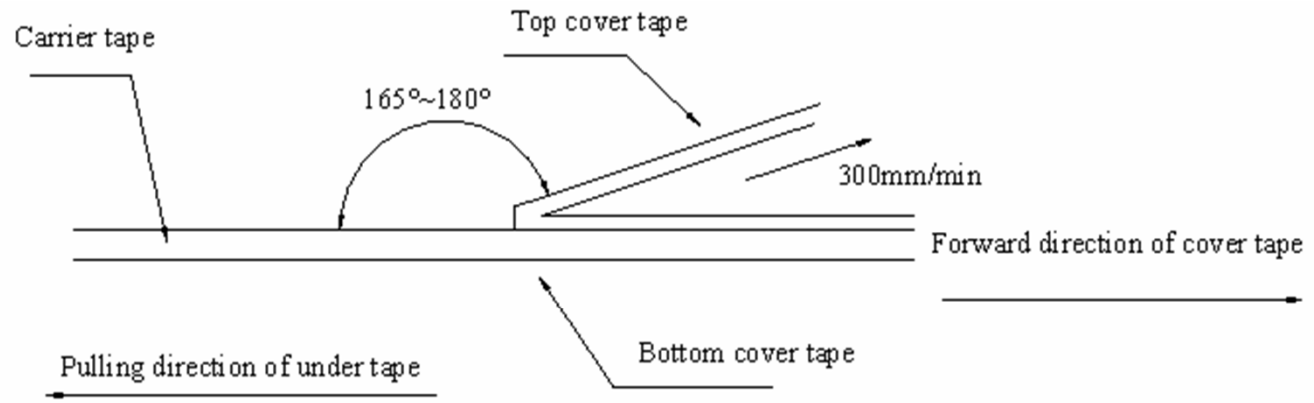


OUTLINE DIMENSION

(Unit : mm)



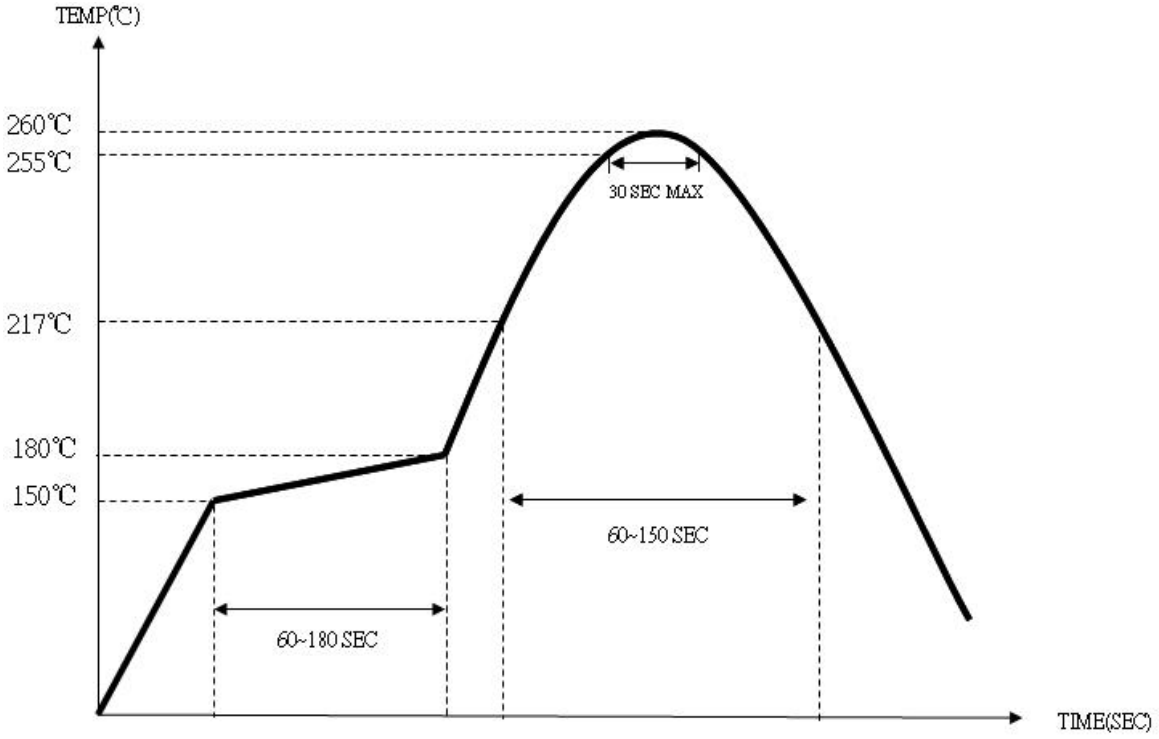
8. COVER TAPE ADHESION STRENGTH：



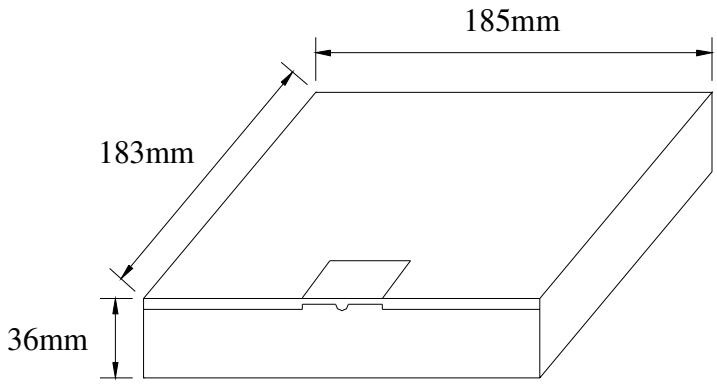
*** In the case, the cover tape is pulled off under the above conditions, the cover tape adhesion strength should be 10.2g~71.4g Plastic tape: 10.2g~71.4g

(Cover tape adhesion strength)

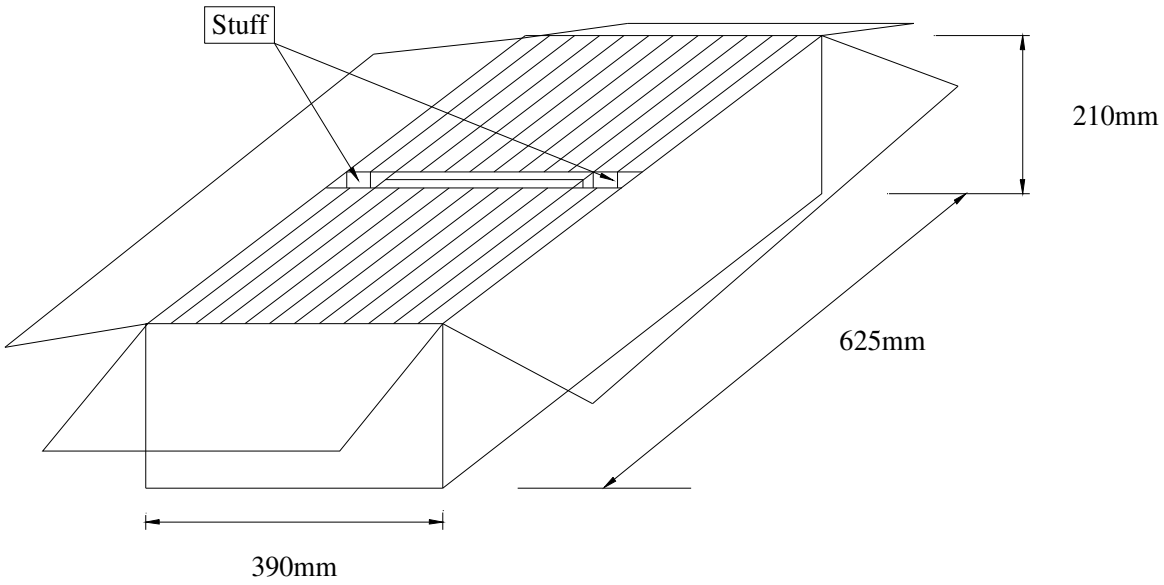
9 . SOLDERING REFLOW PROFILE



10. PACKING :



BOX = 1000 PCS / REEL

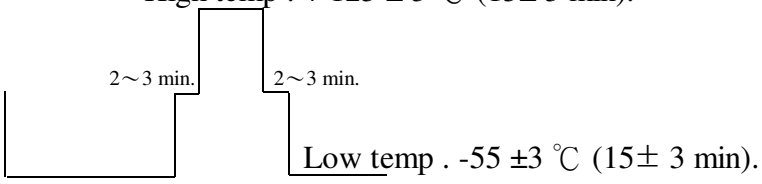


SMD product packs 32 BOX = The outside box packs (1000 PCS * 32 BOX = 32000 PCS)(MAX)

11 . MECHANICAL PERFORMANCE

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
11.1 Drop Test	The specimen is measured for its frequency before the test. It is then dropped from a hight of 100 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness. (in accordance with JIS-C0044)	To satisfy the electrical performance .
11.2 Vibration Test	The specimen is measured for its frequency before the test. Most them into X,Y and Z axes, respectively, for the vibration test. Vibration condition: Frequency range ; 20 ~ 2000HZ Peak to peak amplitude : 1.52 mm Peak acceleration : 20G Sweep time : 20 minute / axis Pendicular total test time : 4 hours (in accordance with MIL-STD-883F : 2007.3)	
11.3 Resistance to Soldering Test	The specimen is measured for its frequency before the test. Place the specimen on the belt of the converynace and let it pass through the reflow with the presetted temperature condition. After passing twice the reflow place,the specimen under the referee condition for -~2 hours and then measure its electrical performance. Temperature Condition of IR Simulation: The temperature range of the preheated section is setted at 150 ~ 180℃ for 60~120 sec. For the next section the temperature range is setted at 217~260℃ for 45~90 sec. and within this time range the specimen should be able to sustain at the peak temperature, 260+/-3℃ , for 10 sec long. (in accordance with JESD22-B106-B)	
11.4 Fine Leak Test	Place the specimen in a pressurized container and pressurize it with the detection gas (mixed gas consisting of 95% or more helium) for at least 2 hours. Complete the measurement of the concentration of helium within 30 min after taking it out from the pressurized container. (in accordance with MIL-STD-883F : 1014.11)	Less than $1.0 * 10^{-8}$ atm .c.c. / sec, Helium
	The referee condition . Temperature 25 ± 2 ℃ Humidity 44 ~ 55 % Pressure 86 ~ 106 kPa (in accordance with MIL-STD-883E : 1014. 9)	

12 . CLIMATIC RESISTANCE

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
12.1 Low Temp Exposure Test	The specimen is measured for its frequency before the test . Place the specimen in the chamber and kept it at the temperature of - 40 ± 3℃ for 168 ± 6 hours . Take the specimen out of the chamber and measure itselectrical performance after leaving 1 ~ 2 hours under the referee condition. (in accordance with JIS-C0020)	To satisfy the electrical performance .
12.2 Aging Test	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and keep it at the temperature of + 125 ± 3℃ for 720 ± 48 hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition . (in accordance with JIS-C0021)	
12.3 High Temperature & High Humidty	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and kept it at the temperature of + 85 ± 5 ℃ and humidity of 85 ± 5 % for 168 ± 6 hours.and then take the specimen out and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition. (in accordance with MIL-STD-883F : 1004.7)	
12.4 Temperature Cycle Test	The specimen is measured for its frequency before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp . + 125 ± 3 ℃ (15± 3 min).  Measure its electrical performance after leaving it for 1 ~ 2 hours under the referee condition . (in accordance with MIL-STD-883F : 1010.8)	